## Notice of References Cited Application/Control No. 10/579,024 Examiner TAN TRINH Applicant(s)/Patent Under Reexamination JIN ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,477,176	11-2002	Hamalainen et al.	370/435
*	В	US-5,740,531	04-1998	Okada, Yasushi	455/403
*	С	US-6,385,585	05-2002	Jonsson et al.	704/275
*	D	US-6,208,959	03-2001	Jonsson et al.	704/209
*	E	US-5,382,951	01-1995	White et al.	340/825.52
*	F	US-2007/0147285	06-2007	Jin et al.	370/329
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					·
	Р					
	Q					
	R					
	S					
	Т					***

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	x	

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